Applicant(s)/Patent Under Application/Control No. Reexamination 09/652,159 LIU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Vanel Frenel 3627 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2005/0261986 11-2005 Haynes et al. 705/026 Α US-2002/0013815 01-2002 Obradovich et al. 709/204 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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